

STS4DNF60

N-channel 60V - 0.070Ω - 4A - SO-8 STripFET[™] Power MOSFET

Features

Туре	V _{DSS}	R _{DS(on)}	I _D
STS4DNF60	60V	<0.090Ω	4A

- Standard outline for easy automated surface mount assembly
- Low threshold drive

Description

This Power MOSFET is the latest development of STMicroelectronics unique "single feature size" strip-based process. The resulting transistor shows extremely high packing density for low onresistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

Application

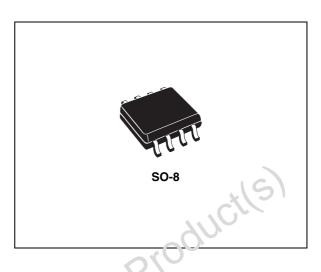


Figure 1. Internal schematic diagram

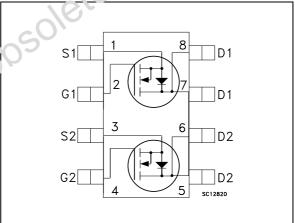


Table 🕚	Device	summary
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Switching applications Tab! Device summer	nary	$\begin{array}{c} G1 \\ \hline \\ S2 \\ \hline \\ G2 \\ \hline \\ 4 \end{array}$	$ \begin{array}{c} $
Order code	Marking	Package	Packaging
STS4DNF60	4DF60	SO-8	Tape & reel

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Electrical ratings 1

Table 2.	Absolute	maximum	ratings
	Absolute	maximum	raungs

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage (V _{GS} = 0)	60	V
V _{GS}	Gate- source voltage	± 20	V
Ι _D	Drain current (continuous) at $T_C = 25^{\circ}C$	4	А
Ι _D	Drain current (continuous) at T _C = 100°C	2.5	А
I _{DM} ⁽¹⁾	Drain current (pulsed)	16	А
P _{TOT} ⁽²⁾	Total dissipation at $T_{C} = 25^{\circ}C$	2	W
T _j T _{stg}	Operating junction temperature Storage temperature	-55 to 150	°C
	dth limited by safe operating area 6W for single operation Thermal data	ductle	5
Symbol	Parameter	Value	Unit

Table 3. Thermal data

Symbol	Parameter	Value	Unit
Rthj-pcb	Thermal resistance junction-pcb D.O. ⁽¹⁾	62.5	°C/W

s 10sec obsolete 1. When mounted on inch² FR-4 board, 2 Oz Cu, t \leq 10sec, dual operation

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Electrical characteristics 2

(Tcase =25°C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 250 \mu A, \ V_{GS} = 0$	60			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	$V_{DS} = Max rating$ $V_{DS} = Max rating, T_{C}=125^{\circ}C$			1 10	μΑ μΑ
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	$V_{GS} = \pm 20V$			± 100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	2		4	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10V, I _D = 2A		0.070	0.090	Ω
Table 5.	Dynamic	-		2019		

Table 4. On /off states

Table 5. Dynamic

	ouncoming amoo					
Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
t _{d(on)} t _r	Turn-on delay time Rise time	$V_{DD} = 30V, I_D = 2A,$ $R_G = 4.7\Omega, V_{GS} = 10V$ (see <i>Figure 12</i>)		7 18		ns ns
t _{d(off)} t _f	Turn-off delay time Fall time	$V_{DD} = 30V, I_D = 2A,$ $R_G = 4.7\Omega, V_{GS} = 10V$ (see <i>Figure 12</i>)		17 6		ns ns

Switching times Table 6.

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD} I _{SDM} ⁽¹⁾	Source-drain current Source-drain current (pulsed)				4 16	A A
V_{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 4A, V_{GS} = 0$			1.2	v
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} = 4A, di/dt = 100A/μs V _{DD} = 20V, T _j = 25°C (see <i>Figure 17</i>)	2	45 68 3		ns nC A
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 4A$, di/dt = 100A/µs $V_{DD} = 20V$, $T_j = 150$ °C (see <i>Figure 17</i>)		50 88 3.5		ns nC A
	Pulse duration = 300 µs, duty cycle					

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2.1 Electrical characteristics (curves)

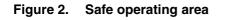
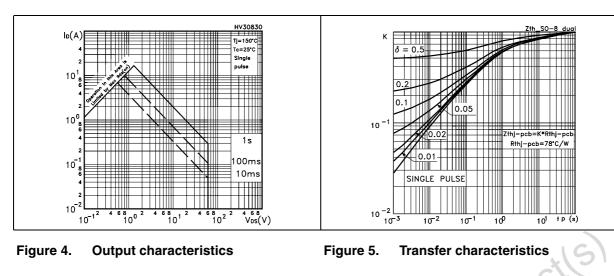


Figure 3. Thermal impedance



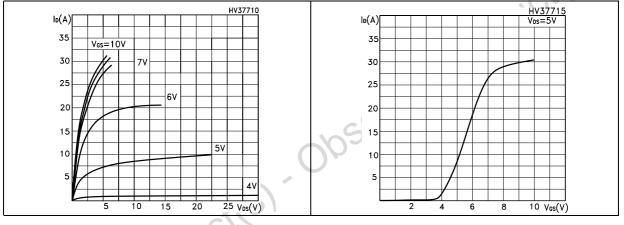
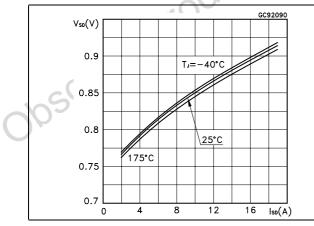
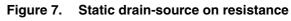
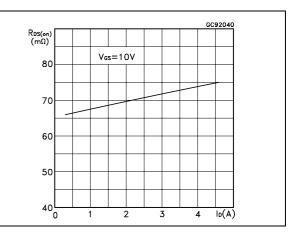


Figure 6. Source-drain diode forward characteristics







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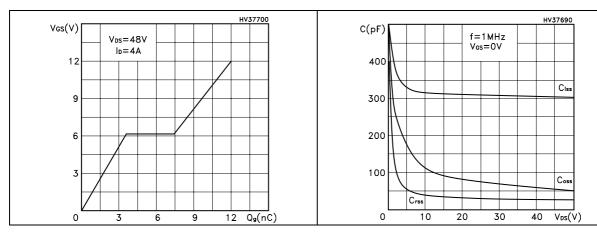
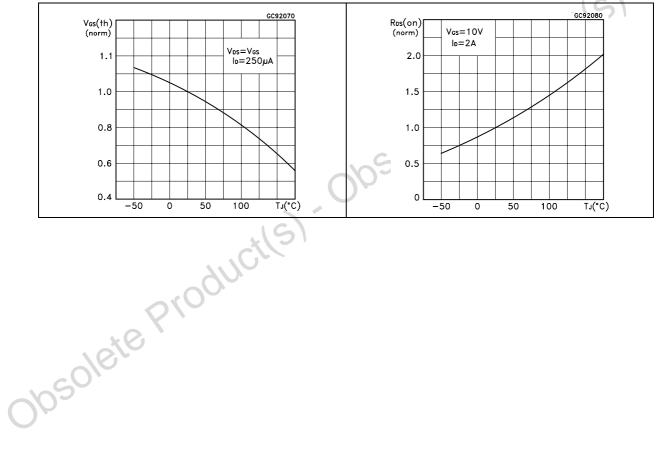


Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations



Figure 11. Normalized on resistance vs temperature

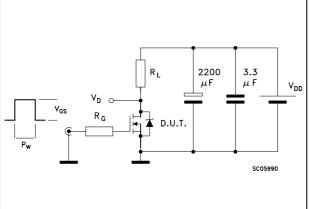




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3 Test circuits

Figure 12. Switching times test circuit for resistive load



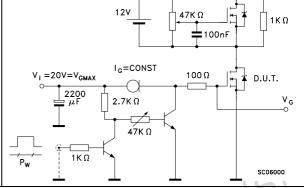
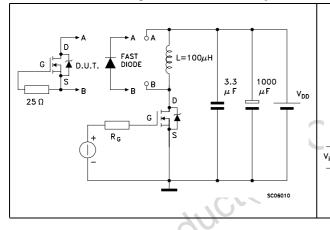


Figure 13. Gate charge test circuit

Figure 14. Test circuit for inductive load switching and diode recovery times





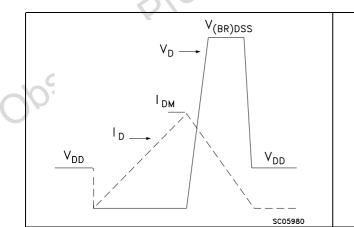


Figure 15. Unclamped Inductive load test circuit

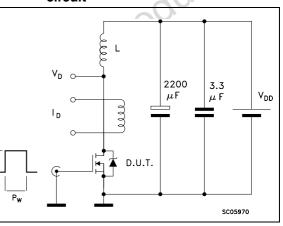
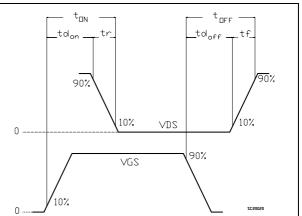


Figure 17. Switching time waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: *www.st.com*

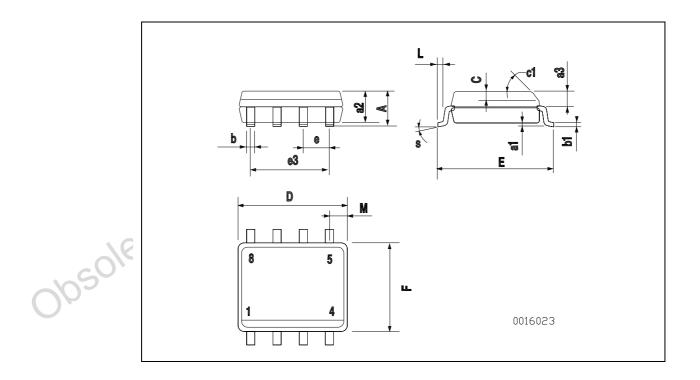
obsolete Product(s). Obsolete Product(s)



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DIM.		mm.			inch	
DIM.	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX
А			1.75			0.068
a1	0.1		0.25	0.003		0.009
a2			1.65			0.064
a3	0.65		0.85	0.025		0.033
b	0.35		0.48	0.013		0.018
b1	0.19		0.25	0.007		0.010
С	0.25		0.5	0.010		0.019
c1			45 ((typ.)		
D	4.8		5.0	0.188		0.196
E	5.8		6.2	0.228		0.244
е		1.27			0.050	
e3		3.81			0.150	
F	3.8		4.0	0.14		0.157
L	0.4		1.27	0.015		0.050
М			0.6			0.023

SO-8 MECHANICAL DATA



5 Revision history

Table 8.	Revision	history
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Date	Revision	Changes
17-May-2007	1	First release
02-Aug-2007	2	Marking has been updated

obsolete Product(s). Obsolete Product(s)

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